

### Features

- 100V/150A,
- $R_{DS(on)} = 3.2\text{m}\Omega(\text{Typ.}) @ V_{GS} = 10\text{V}$
- Advanced HEFET® Technology
- Ultra Low On-Resistance
- Excellent  $Q_g \times R_{DS(on)}$  Product
- 100% avalanche tested
- 175°C Operating Temperature
- Lead Free and Green Devices Available (RoHS Compliant)

### Applications



Pb-Free

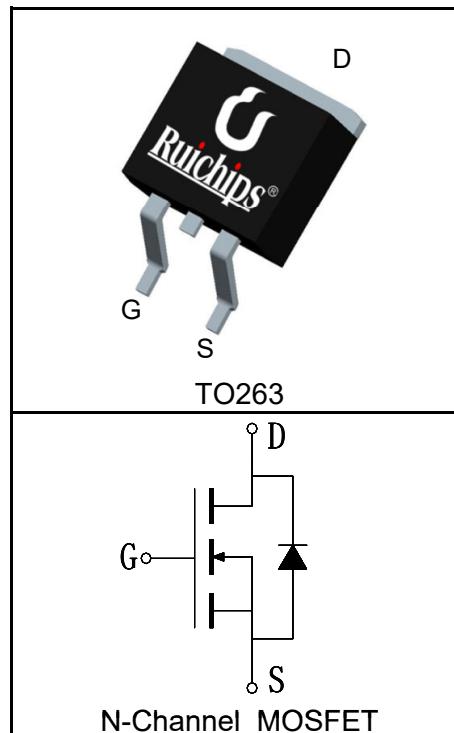


RoHS



Halogen-Free

### Pin Description



### Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
<b>Common Ratings</b> ( $T_c = 25^\circ\text{C}$ Unless Otherwise Noted)			
$V_{DSS}$	Drain-Source Voltage	100	V
$V_{GSS}$	Gate-Source Voltage	$\pm 25$	
$T_J$	Maximum Junction Temperature	175	°C
$T_{STG}$	Storage Temperature Range	-55 to 175	°C
$I_S$	Diode Continuous Forward Current	$T_c = 25^\circ\text{C}$	A
<b>Mounted on Large Heat Sink</b>			
$I_{DP}^{(1)}$	300μs Pulse Drain Current Tested	$T_c = 25^\circ\text{C}$	600
$I_D^{(2)}$	Continuous Drain Current( $V_{GS} = 10\text{V}$ )	$T_c = 25^\circ\text{C}$	150
		$T_c = 100^\circ\text{C}$	106
$P_D$	Maximum Power Dissipation	$T_c = 25^\circ\text{C}$	200
		$T_c = 100^\circ\text{C}$	100
$R_{\theta JC}$	Thermal Resistance-Junction to Case	0.75	°C/W
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	62.5	°C/W
<b>Drain-Source Avalanche Ratings</b>			
$E_{AS}^{(3)}$	Avalanche Energy, Single Pulsed	440	mJ

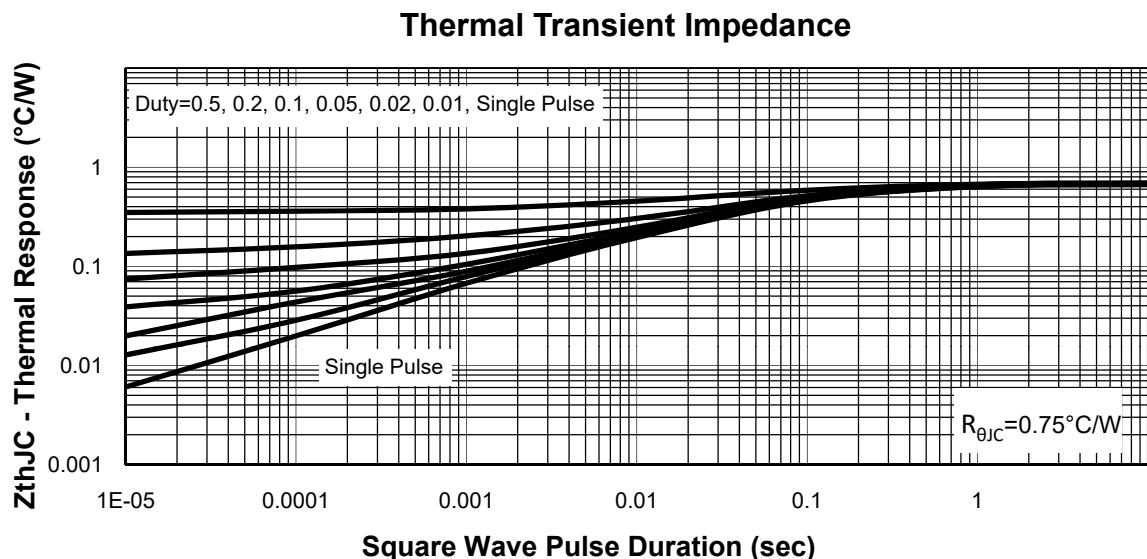
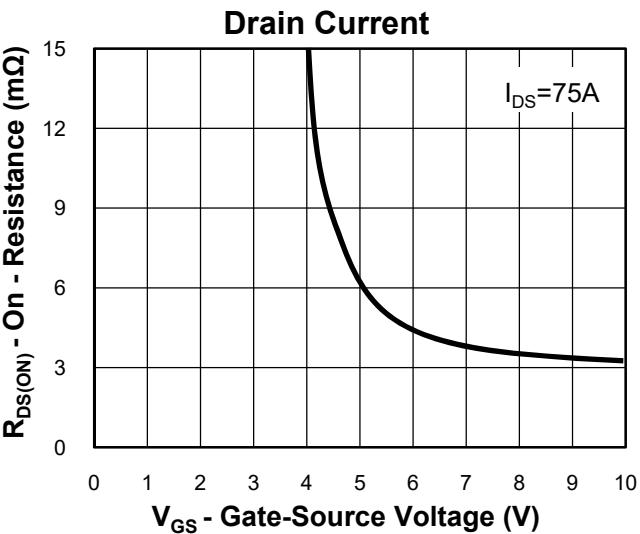
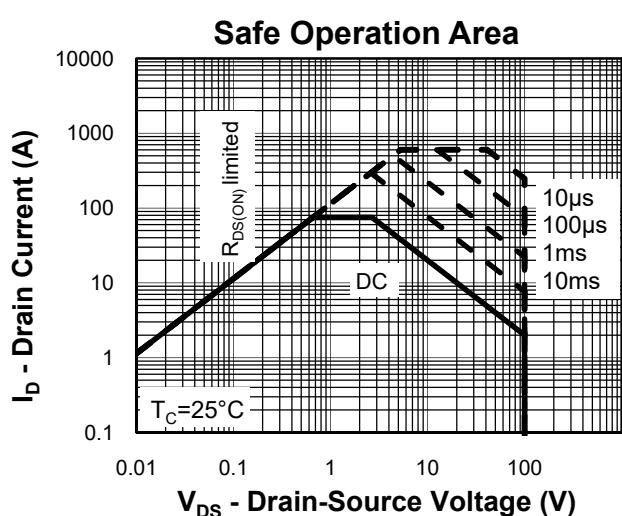
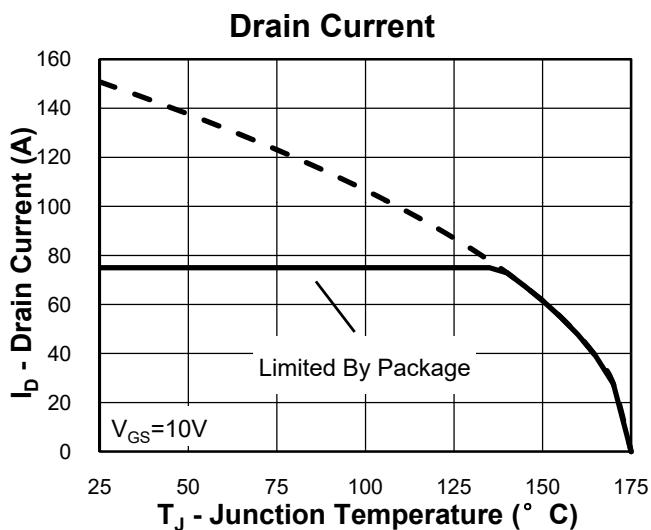
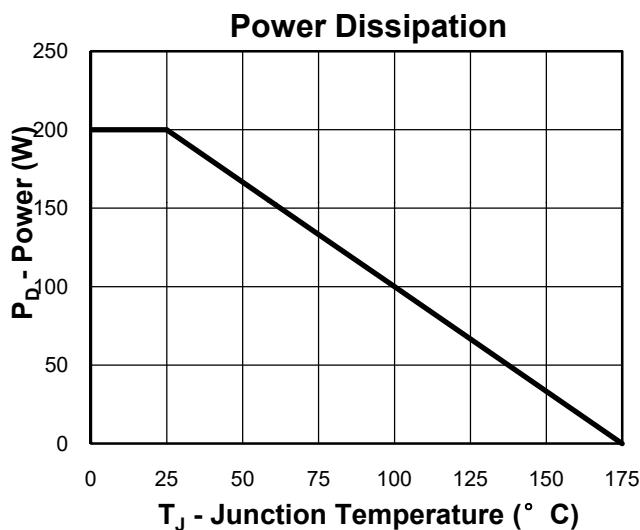
**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Test Condition	RUH1H150S			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_{\text{DS}}=250\mu\text{A}$	100			V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=100\text{V}, \text{V}_{\text{GS}}=0\text{V}$			1	$\mu\text{A}$
		$\text{T}_J=125^\circ\text{C}$			30	
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{DS}}=250\mu\text{A}$	2		4	V
$\text{I}_{\text{GSS}}$	Gate Leakage Current	$\text{V}_{\text{GS}}=\pm 25\text{V}, \text{V}_{\text{DS}}=0\text{V}$			$\pm 100$	nA
$\text{R}_{\text{DS}(\text{ON})}^{(4)}$	Drain-Source On-state Resistance	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{DS}}=75\text{A}$		3.2	4	mΩ
<b>Diode Characteristics</b>						
$\text{V}_{\text{SD}}^{(4)}$	Diode Forward Voltage	$\text{I}_{\text{SD}}=75\text{A}, \text{V}_{\text{GS}}=0\text{V}$			1.2	V
$\text{t}_{\text{rr}}$	Reverse Recovery Time	$\text{I}_{\text{SD}}=75\text{A}, \frac{d\text{I}_{\text{SD}}}{dt}=100\text{A}/\mu\text{s}$		36		ns
$\text{Q}_{\text{rr}}$	Reverse Recovery Charge			28		nC
<b>Dynamic Characteristics</b> <sup>(5)</sup>						
$\text{R}_G$	Gate Resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{F}=1\text{MHz}$		2.1		Ω
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V},$		3650		pF
$\text{C}_{\text{oss}}$	Output Capacitance	$\text{V}_{\text{DS}}=50\text{V},$		750		
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance	Frequency=1.0MHz		27		
$\text{t}_{\text{d}(\text{ON})}$	Turn-on Delay Time	$\text{V}_{\text{DD}}=50\text{V}, \text{I}_{\text{DS}}=75\text{A},$ $\text{V}_{\text{GEN}}=10\text{V}, \text{R}_G=2.5\Omega$		24		ns
$\text{t}_r$	Turn-on Rise Time			13		
$\text{t}_{\text{d}(\text{OFF})}$	Turn-off Delay Time			49		
$\text{t}_f$	Turn-off Fall Time			17		
<b>Gate Charge Characteristics</b> <sup>(5)</sup>						
$\text{Q}_g$	Total Gate Charge	$\text{V}_{\text{DS}}=80\text{V}, \text{V}_{\text{GS}}=10\text{V},$ $\text{I}_{\text{DS}}=75\text{A}$		87		nC
$\text{Q}_{\text{gs}}$	Gate-Source Charge			23		
$\text{Q}_{\text{gd}}$	Gate-Drain Charge			15		

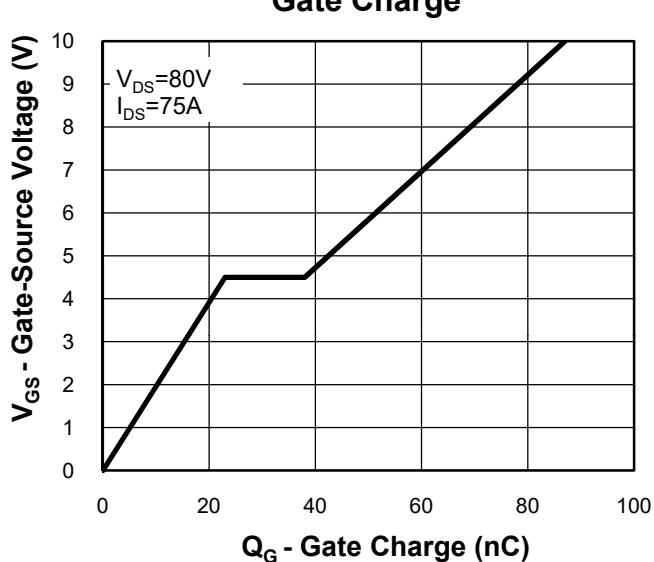
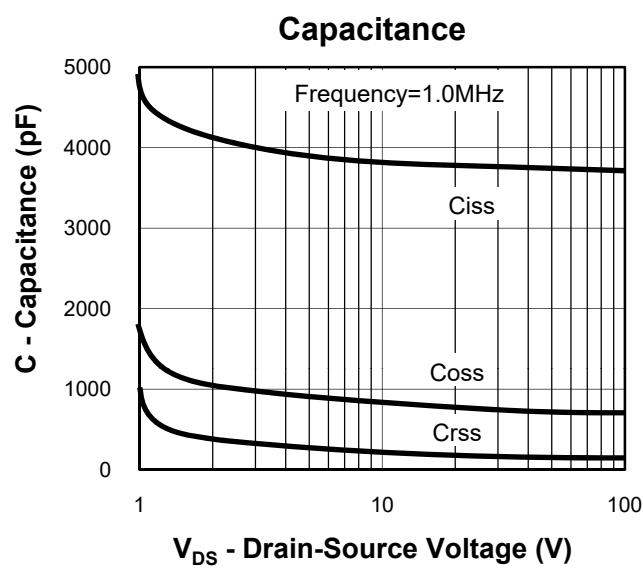
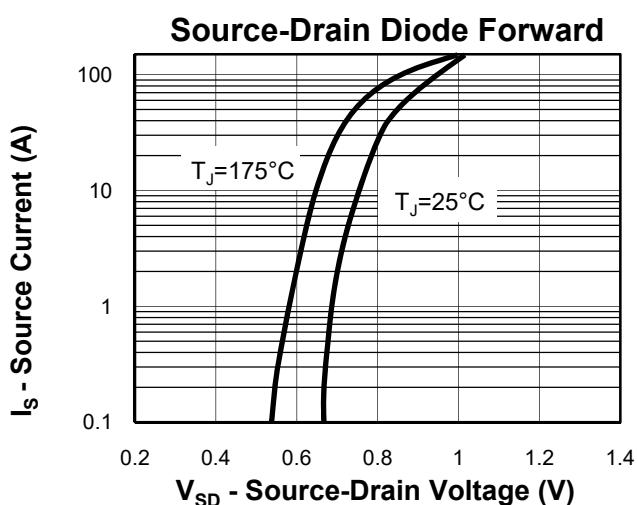
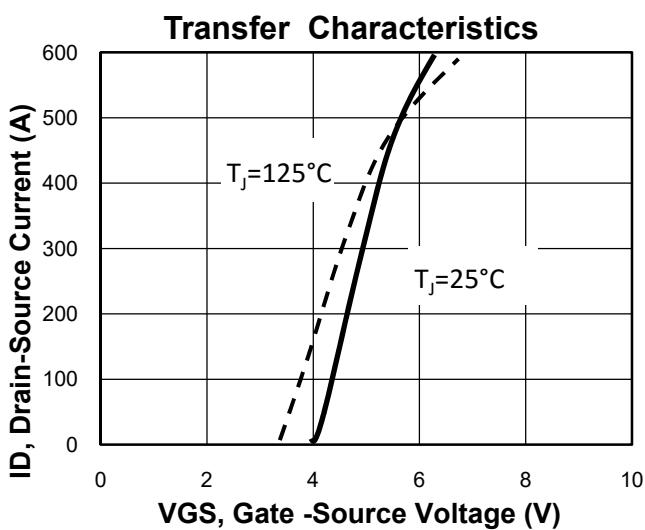
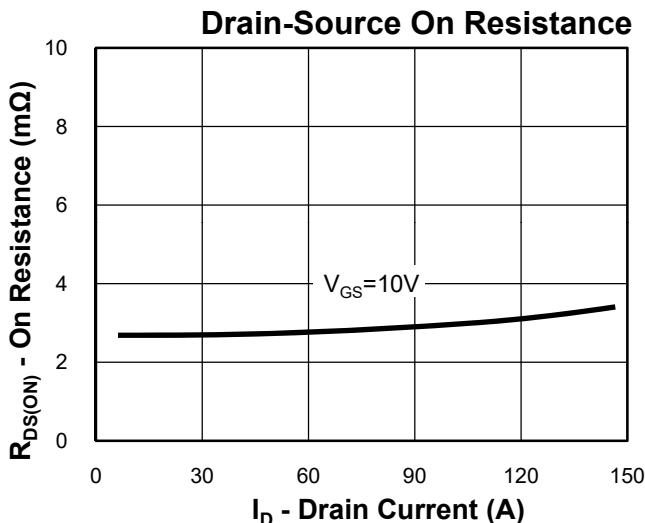
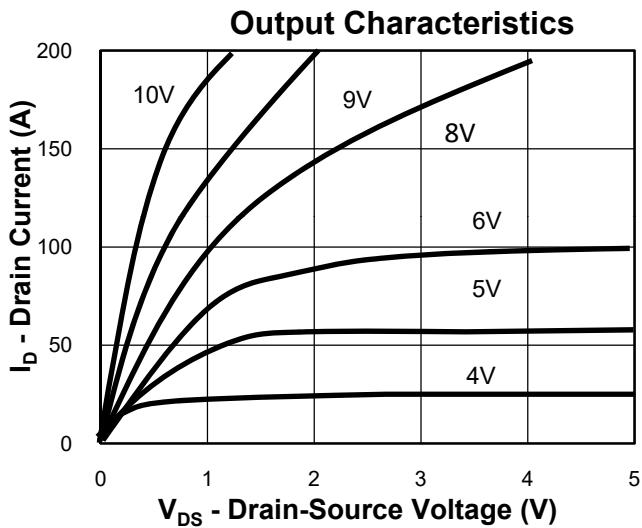
Notes:

- (1)Pulse width limited by safe operating area.
- (2)Calculated continuous current based on maximum allowable junction temperature. The package limitation current is 75A.
- (3)Limited by  $T_{J\max}$ ,  $I_{AS}=42\text{A}$ ,  $V_{DD}=60\text{V}$ ,  $R_G=50\Omega$ , Starting  $T_J=25^\circ\text{C}$ .
- (4)Pulse test; Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- (5)Guaranteed by design, not subject to production testing.

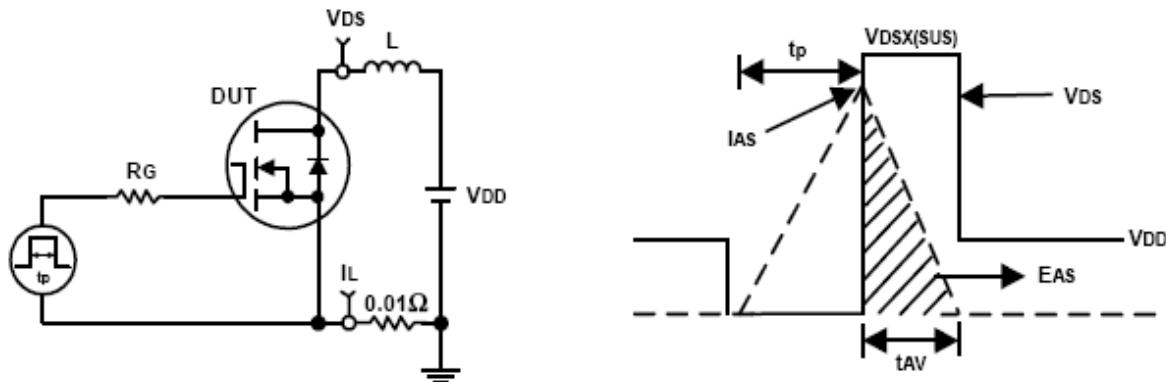
### Typical Characteristics



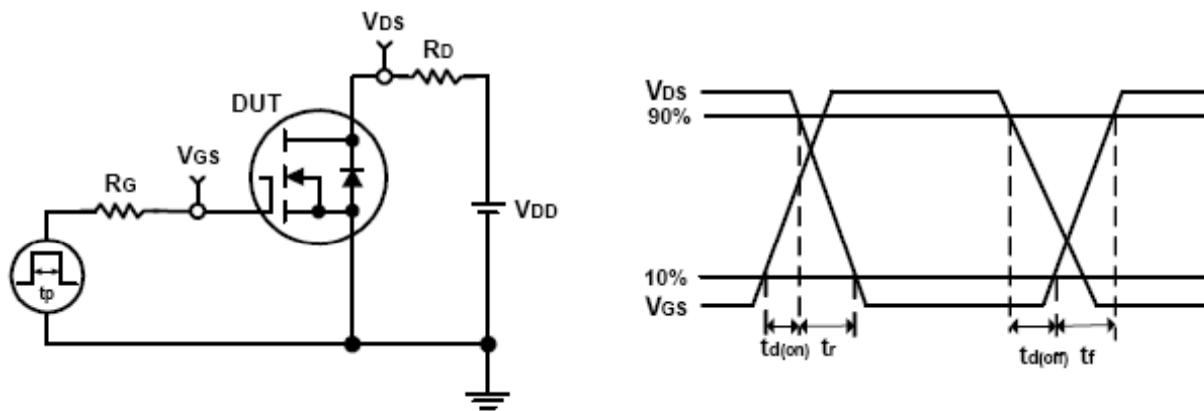
### Typical Characteristics



### Avalanche Test Circuit and Waveforms



### Switching Time Test Circuit and Waveforms

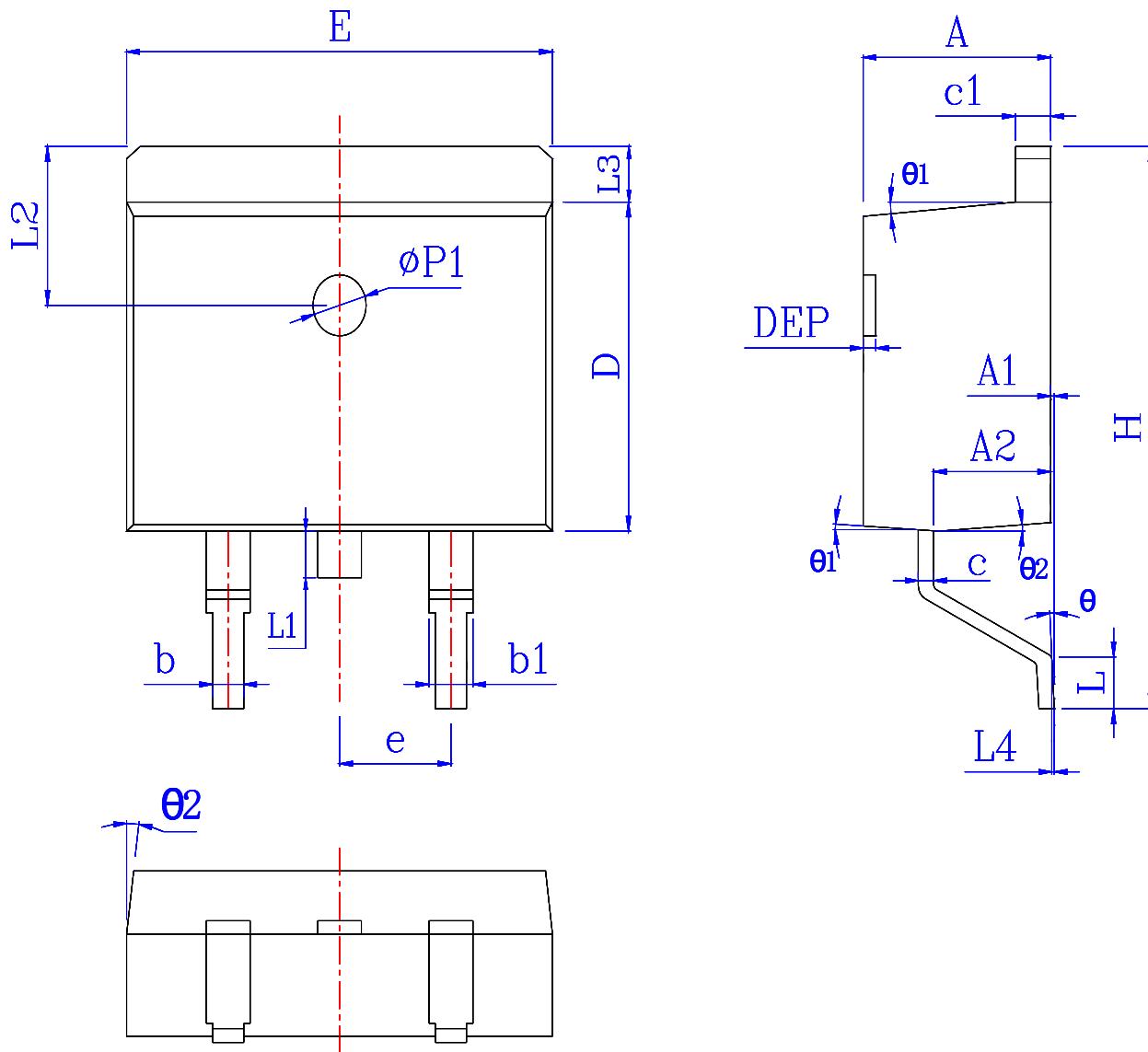


### Ordering and Marking Information

Device	Marking	Package	Packaging	Quantity	Reel Size	Tape width
RUH1H150S	RUH1H150S	TO263	Tube	50	-	-
RUH1H150S-R	RUH1H150S	TO263	Tape&Reel	800	13"	24mm

## Package Information

TO263



SYMBOL	MM			INCH			SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX		MIN	NOM	MAX	MIN	NOM	MAX
A	4.30	4.55	4.85	0.169	0.179	0.191	L	1.94	2.30	2.79	0.076	0.091	0.110
A1	0.00	0.10	0.25	0.000	0.005	0.010	L3	1.02	1.29	1.40	0.040	0.051	0.055
A2	2.20	2.69	2.79	0.087	0.106	0.110	L1	*	*	1.70	*	*	0.067
b	0.70	*	1.00	0.028	*	0.039	L4	0.25 BSC			0.01 BSC		
b1	1.14	*	1.47	0.045	*	0.058	L2	2.50 REF			0.098 REF		
c	0.33	*	0.65	0.013	*	0.026	$\theta$	0°	*	8°	0°	*	8°
c1	1.15	*	1.45	0.045	*	0.057	$\theta_1$	5°	7°	9°	5°	7°	9°
D	8.59	*	9.40	0.338	*	0.370	$\theta_2$	1°	3°	5°	1°	3°	5°
E	9.66	*	10.40	0.380	*	0.409	DEP	0.05	0.10	0.20	0.002	0.004	0.008
e	2.54BSC			0.100BSC			$\phi P1$	1.40	1.50	1.60	0.055	0.059	0.063
H	14.70	15.10	15.79	0.579	0.594	0.622							